

## NTE3034A Silicon NPN Phototransistor

## Features:

• Spectral Range of Sensitivity: 450 to 1100nm (Typ)

• Package: Sidelooker, Epoxy

High Photosensitivity

## **Applications:**

- A Variety of Manufacturing and Monitoring Applications
- Photointerrupters

Absolute Maximum Ratings: (T <sub>A</sub> = +25°C unless otherwise specified)	
Collector–Emitter Voltage, V <sub>CE</sub>	30V
Emitter-Collector Voltage, V <sub>EC</sub>	7V
Collector Current, I <sub>C</sub>	50mA
Collector Surge Current ( $\tau$ < 10 $\mu$ s), I <sub>CS</sub>	100mA
Total Power Dissipation, P <sub>tot</sub>	100mW
Operating Temperature Range, Topr	40° to +100°C
Storage Temperature Range, T <sub>stg</sub>	
Thermal Resistance, Junction-to-Ambient, RthJA	750K/W
ESD Withstand Voltage, V <sub>ESO</sub>	2000V

## **Characteristics:** $(T_A = +25^{\circ}C \text{ unless otherwise specified})$

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
Wavelength of Maximum Sensitivity	I <sub>S max</sub>		_	880	_	nm
Radiant Sensitivity Area	Α		_	0.11	_	mm <sup>2</sup>
Dimensions of Chip Area	LxW		0.55	x .0.55	(Тур)	mm
Half Angle	φ		_	±35	_	0
Capacitance	C <sub>CE</sub>	V <sub>CE</sub> = 0V, f = 1MHz, E = 0	_	7.5	_	pF
Photocurrent	I <sub>PCE</sub>	$\lambda = 950$ nm, $E_0 = 0.5$ mW/cm <sup>2</sup> , $V_{CE} = 5$ V	250	_	_	μΑ
		E <sub>V</sub> = 1000 lx, Std. Light A, V <sub>CE</sub> = 5V	_	3200	_	μΑ
Dark Current	I <sub>CEO</sub>	V <sub>CE</sub> = 20V, E = 0	_	1	50	nA
Rise and Fall Time	t <sub>r</sub> , t <sub>f</sub>	$I_C = 1$ mA, $V_{CC} = 5$ V, $R_L = 1$ k $\Omega$	_	10	_	μS
Collector-Emitter saturation Voltage	V <sub>CE(sat)</sub>	Threefold Saturated	_	150	_	mV

